
 Substitute Form PTO-1449  
 (Modified)

 U.S. Department of Commerce  
 Patent and Trademark Office

 Attorney's Docket No.  
 12406-003001

 Application No.  
 09/221,789

**Information Disclosure Statement  
 by Applicant**

(Use several sheets if necessary)

 Applicant  
 Ulrike Reeh et al.

 Filing Date  
 December 28, 1998

 Group Art Unit  
 2815

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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Examiner Signature

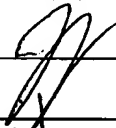

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Substitute Disclosure Form (PTO-1449)



Substitute Form PTO-1449 (Modified)  <b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12406-003001	Application No. 09/221,789
	Applicant Ulrike Reeh et al.		
	Filing Date December 28, 1998	Group Art Unit 2815	


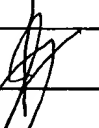
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	BB						

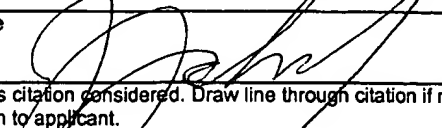
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							Yes	No
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Examiner Signature 	Date Considered 9/05
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	CJ	Möllmer et al., "Siemens SMT TOP-LED for Surface Mounting", <u>Siemens Components</u> , Bd. 26, No. 6, pp. 193-196 (1991)
	CK	Translation of Japanese Office Action Dated June 2, 2005
	CL	Notice of European Opposition Dated February 28, 2005
	CM	Six European Search Reports dated May 25, 2005
	CN	<i>In the Matter of Certain Light-Emitting Diodes and Products Containing Same</i> , Investigation No. 337-TA-512, "Notice of Commission Final Determination of No Violation of Section 337 as to One Patent and Determination to Remand the Investigation as Certain Other Patents," Dated August 10, 2005
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	CP	<i>In the Matter of Certain Light-Emitting Diodes and Products Containing Same</i> , Investigation No. 337-TA-512, "Commission Opinion," (Public Version), Dated August 29, 2005
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	CR	

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